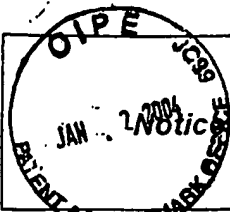


4003

	Notice of References Cited		Application/Control No. 2001/159,265	Applicant(s)/Patent Under Reexamination BENDALE ET AL	
			Examiner Eric W Thomas	Art Unit 2831	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
1m	A	US-6,282,081	08-2001	Takabayashi et al.	361/502
1m	B	US-2002/0110729	08-2002	Hozumi et al.	429/130
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
1m	N	1033729	09-2000	EP	Miura et al.	H01G 9/12
1m	O	9/298129	11-1997	JP	—	H01G 9/00
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

11m

05-26-4